

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V				1	μA
			T _J =55°C			5	μΛ
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.5	2.0	2.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =10A			12	15	mΩ
			T _J =125°C		20.5	25	
		V_{GS} =4.5V, I_D =9A			15	19	mΩ
g FS	Forward Transconductance	V _{DS} =5V, I _D =10A			35		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.72	1	V
I _S	Maximum Body-Diode Continuous Cur	rent				4	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz			1340		pF
C _{oss}	Output Capacitance				123		pF
C _{rss}	Reverse Transfer Capacitance				10		pF
R_g	Gate resistance	f=1MHz		0.7	1.5	2.3	Ω
SWITCH	NG PARAMETERS	•	·		•	•	•
Q _g (10V)	Total Gate Charge	- -V _{GS} =10V, V _{DS} =30V, I _D =10A			21	30	nC
Q _g (4.5V)	Total Gate Charge				9	15	nC
Q_{gs}	Gate Source Charge				4.7		nC
Q_{gd}	Gate Drain Charge				2.6		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =30V, R_L =3.0 Ω , R_{GEN} =3 Ω			6		ns
t _r	Turn-On Rise Time				2.5		ns
t _{D(off)}	Turn-Off DelayTime				22		ns
t _f	Turn-Off Fall Time				2.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A, dI/dt=500A/μs			15.5		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =10A, dI/dt=500A/μs			55.5		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leq 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep

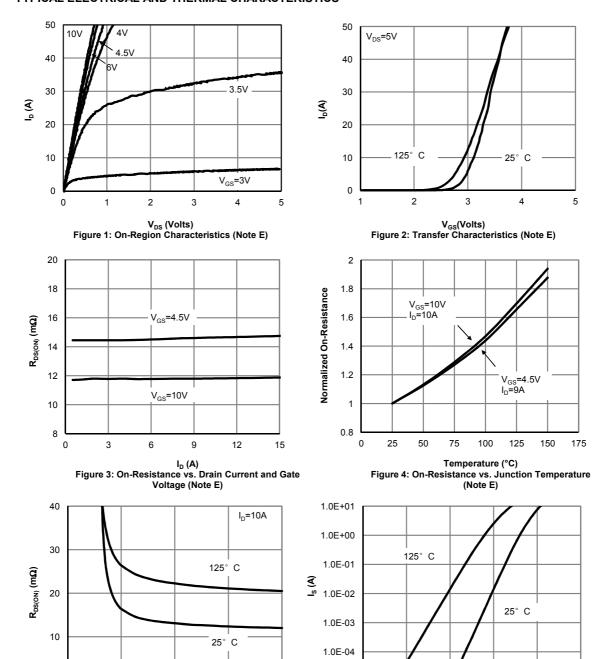
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initialT_J=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.



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1.0E-05

0.0

0.2

0.4

V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

0.6

0.8

1.0

10

0

2

6

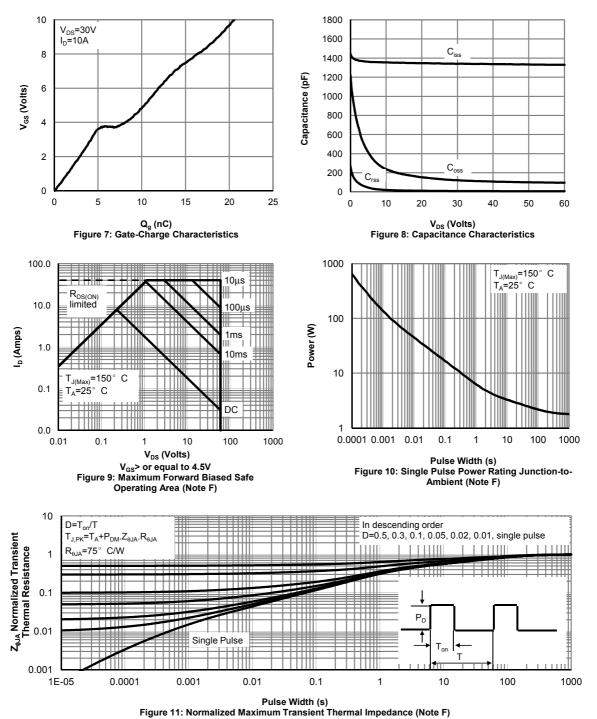
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)

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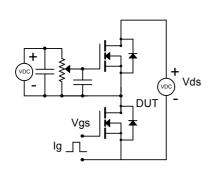
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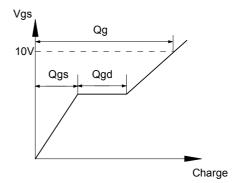


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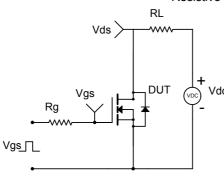


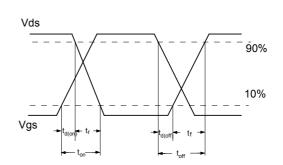
Gate Charge Test Circuit & Waveform



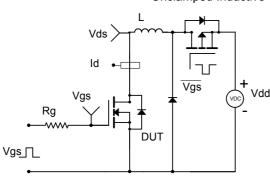


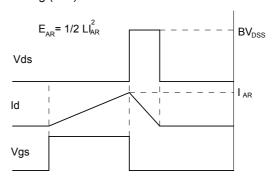
Resistive Switching Test Circuit & Waveforms



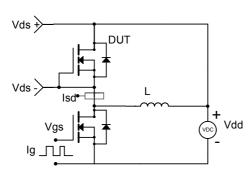


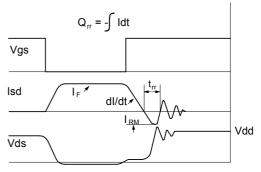
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





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